



# PSMN2R1-40PL

N-channel 40 V, 2.2 mΩ logic level MOSFET in SOT78

1 February 2013

Product data sheet

## 1. General description

Logic level N-channel MOSFET in SOT78 using TrenchMOS technology. Product design and manufacture has been optimized for use in battery operated power tools.

## 2. Features and benefits

- High efficiency due to low switching & conduction losses
- Robust construction for demanding applications
- Logic level gate

## 3. Applications

- Battery-powered tools
- Load switching
- Motor control
- Uninterruptible power supplies

## 4. Quick reference data

Table 1. Quick reference data

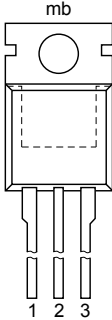
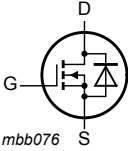
| Symbol                  | Parameter                                    | Conditions                                                                                                                                                       |     | Min | Typ   | Max   | Unit |
|-------------------------|----------------------------------------------|------------------------------------------------------------------------------------------------------------------------------------------------------------------|-----|-----|-------|-------|------|
| V <sub>DS</sub>         | drain-source voltage                         | T <sub>J</sub> ≥ 25 °C; T <sub>J</sub> ≤ 175 °C                                                                                                                  |     | -   | -     | 40    | V    |
| I <sub>D</sub>          | drain current                                | V <sub>GS</sub> = 10 V; T <sub>mb</sub> = 25 °C; <a href="#">Fig. 1</a>                                                                                          | [1] | -   | -     | 150   | A    |
| P <sub>tot</sub>        | total power dissipation                      | T <sub>mb</sub> = 25 °C; <a href="#">Fig. 2</a>                                                                                                                  |     | -   | -     | 293   | W    |
| Static characteristics  |                                              |                                                                                                                                                                  |     |     |       |       |      |
| R <sub>DSon</sub>       | drain-source on-state resistance             | V <sub>GS</sub> = 10 V; I <sub>D</sub> = 25 A; T <sub>J</sub> = 25 °C; <a href="#">Fig. 11</a>                                                                   |     | -   | 1.8   | 2.2   | mΩ   |
| Dynamic characteristics |                                              |                                                                                                                                                                  |     |     |       |       |      |
| Q <sub>G(tot)</sub>     | total gate charge                            | V <sub>GS</sub> = 10 V; I <sub>D</sub> = 25 A; V <sub>DS</sub> = 32 V; <a href="#">Fig. 13</a> ; <a href="#">Fig. 14</a>                                         |     | -   | 168.9 | -     | nC   |
| Q <sub>GD</sub>         | gate-drain charge                            |                                                                                                                                                                  |     | -   | 29.6  | -     | nC   |
| Avalanche ruggedness    |                                              |                                                                                                                                                                  |     |     |       |       |      |
| E <sub>DS(AL)S</sub>    | non-repetitive drain-source avalanche energy | I <sub>D</sub> = 150 A; V <sub>sup</sub> ≤ 40 V; R <sub>GS</sub> = 50 Ω; V <sub>GS</sub> = 10 V; T <sub>j(init)</sub> = 25 °C; unclamped; <a href="#">Fig. 3</a> |     | -   | -     | 490.3 | mJ   |

[1] Continuous current is limited by package.



## 5. Pinning information

Table 2. Pinning information

| Pin | Symbol | Description | Simplified outline                                                                                        | Graphic symbol                                                                      |
|-----|--------|-------------|-----------------------------------------------------------------------------------------------------------|-------------------------------------------------------------------------------------|
| 1   | G      | gate        |  <p>TO-220AB (SOT78)</p> |  |
| 2   | D      | drain       |                                                                                                           |                                                                                     |
| 3   | S      | source      |                                                                                                           |                                                                                     |

## 6. Ordering information

Table 3. Ordering information

| Type number  | Package  |                                                                                  |         |
|--------------|----------|----------------------------------------------------------------------------------|---------|
|              | Name     | Description                                                                      | Version |
| PSMN2R1-40PL | TO-220AB | plastic single-ended package; heatsink mounted; 1 mounting hole; 3-lead TO-220AB | SOT78   |

## 7. Marking

Table 4. Marking codes

| Type number  | Marking code |
|--------------|--------------|
| PSMN2R1-40PL | PSMN2R1-40PL |

## 8. Limiting values

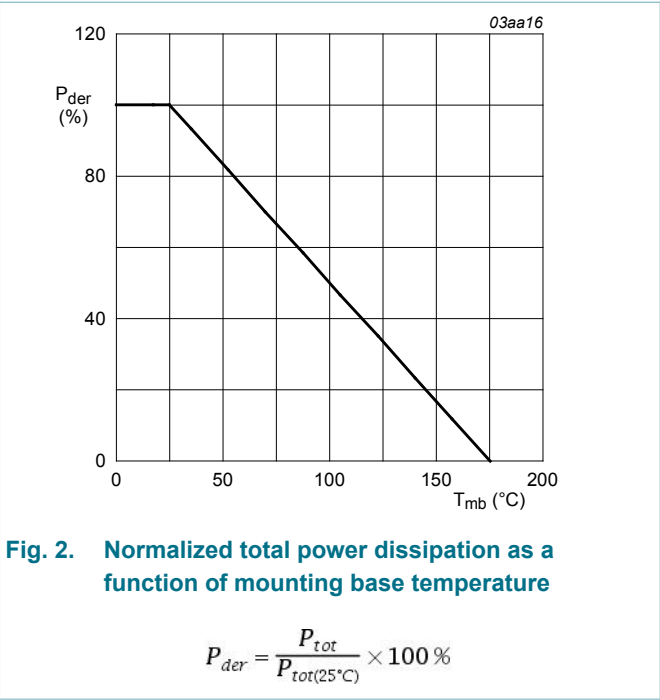
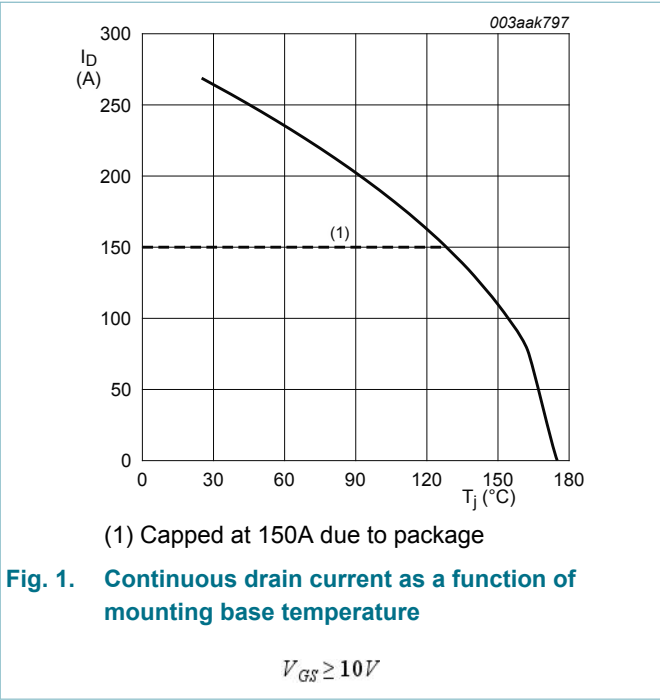
Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol    | Parameter            | Conditions                                                                                |     | Min | Max  | Unit |
|-----------|----------------------|-------------------------------------------------------------------------------------------|-----|-----|------|------|
| $V_{DS}$  | drain-source voltage | $T_j \geq 25\text{ }^{\circ}\text{C}$ ; $T_j \leq 175\text{ }^{\circ}\text{C}$            |     | -   | 40   | V    |
| $V_{DGR}$ | drain-gate voltage   | $R_{GS} = 20\text{ k}\Omega$                                                              |     | -   | 40   | V    |
| $V_{GS}$  | gate-source voltage  |                                                                                           |     | -20 | 20   | V    |
| $I_D$     | drain current        | $T_{mb} = 100\text{ }^{\circ}\text{C}$ ; $V_{GS} = 10\text{ V}$ ; Fig. 1                  | [1] | -   | 150  | A    |
|           |                      | $T_{mb} = 25\text{ }^{\circ}\text{C}$ ; $V_{GS} = 10\text{ V}$ ; Fig. 1                   | [1] | -   | 150  | A    |
| $I_{DM}$  | peak drain current   | $T_{mb} = 25\text{ }^{\circ}\text{C}$ ; pulsed; $t_p \leq 10\text{ }\mu\text{s}$ ; Fig. 4 |     | -   | 1075 | A    |

| Symbol               | Parameter                                    | Conditions                                                                                                                                                             |                     | Min | Max   | Unit |
|----------------------|----------------------------------------------|------------------------------------------------------------------------------------------------------------------------------------------------------------------------|---------------------|-----|-------|------|
| P <sub>tot</sub>     | total power dissipation                      | T <sub>mb</sub> = 25 °C; <a href="#">Fig. 2</a>                                                                                                                        |                     | -   | 293   | W    |
| T <sub>stg</sub>     | storage temperature                          |                                                                                                                                                                        |                     | -55 | 175   | °C   |
| T <sub>j</sub>       | junction temperature                         |                                                                                                                                                                        |                     | -55 | 175   | °C   |
| T <sub>sld(M)</sub>  | peak soldering temperature                   |                                                                                                                                                                        |                     | -   | 260   | °C   |
| Source-drain diode   |                                              |                                                                                                                                                                        |                     |     |       |      |
| I <sub>S</sub>       | source current                               | T <sub>mb</sub> = 25 °C                                                                                                                                                | <a href="#">[1]</a> | -   | 150   | A    |
| I <sub>SM</sub>      | peak source current                          | pulsed; t <sub>p</sub> ≤ 10 μs; T <sub>mb</sub> = 25 °C                                                                                                                |                     | -   | 1075  | A    |
| Avalanche ruggedness |                                              |                                                                                                                                                                        |                     |     |       |      |
| E <sub>DS(AL)S</sub> | non-repetitive drain-source avalanche energy | I <sub>D</sub> = 150 A; V <sub>sup</sub> ≤ 40 V; R <sub>GS</sub> = 50 Ω;<br>V <sub>GS</sub> = 10 V; T <sub>j(init)</sub> = 25 °C; unclamped;<br><a href="#">Fig. 3</a> |                     | -   | 490.3 | mJ   |

[1] Continuous current is limited by package.



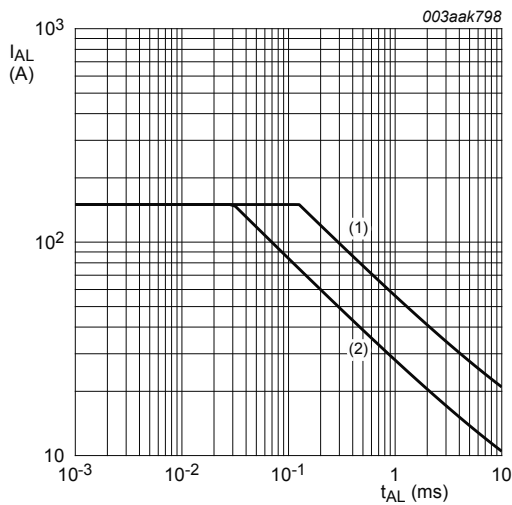


Fig. 3. Avalanche rating; avalanche current as a function of avalanche time

(1)  $T_{j(jnt)} = 25^{\circ}C$ ; (2)  $T_{j(jnt)} = 100^{\circ}C$

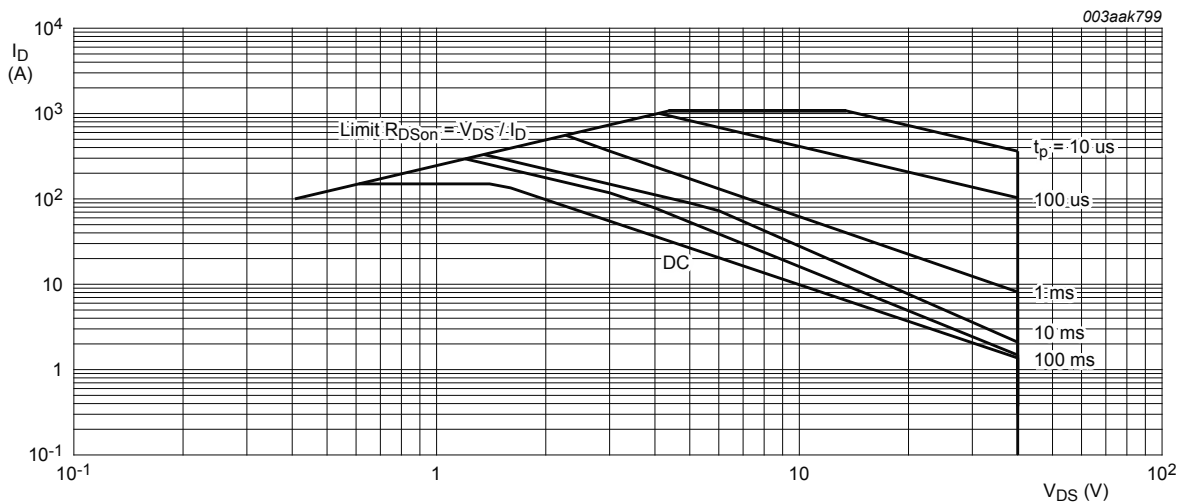


Fig. 4. Safe operating area; continuous and peak drain currents as a function of drain-source voltage

$T_{mb} = 25^{\circ}C$ ;  $I_{DM}$  is a single pulse

9. Thermal characteristics

Table 6. Thermal characteristics

| Symbol         | Parameter                                         | Conditions            | Min | Typ  | Max  | Unit |
|----------------|---------------------------------------------------|-----------------------|-----|------|------|------|
| $R_{th(j-mb)}$ | thermal resistance from junction to mounting base | Fig. 5                | -   | 0.44 | 0.51 | K/W  |
| $R_{th(j-a)}$  | thermal resistance from junction to ambient       | vertical in still air | -   | 60   | -    | K/W  |

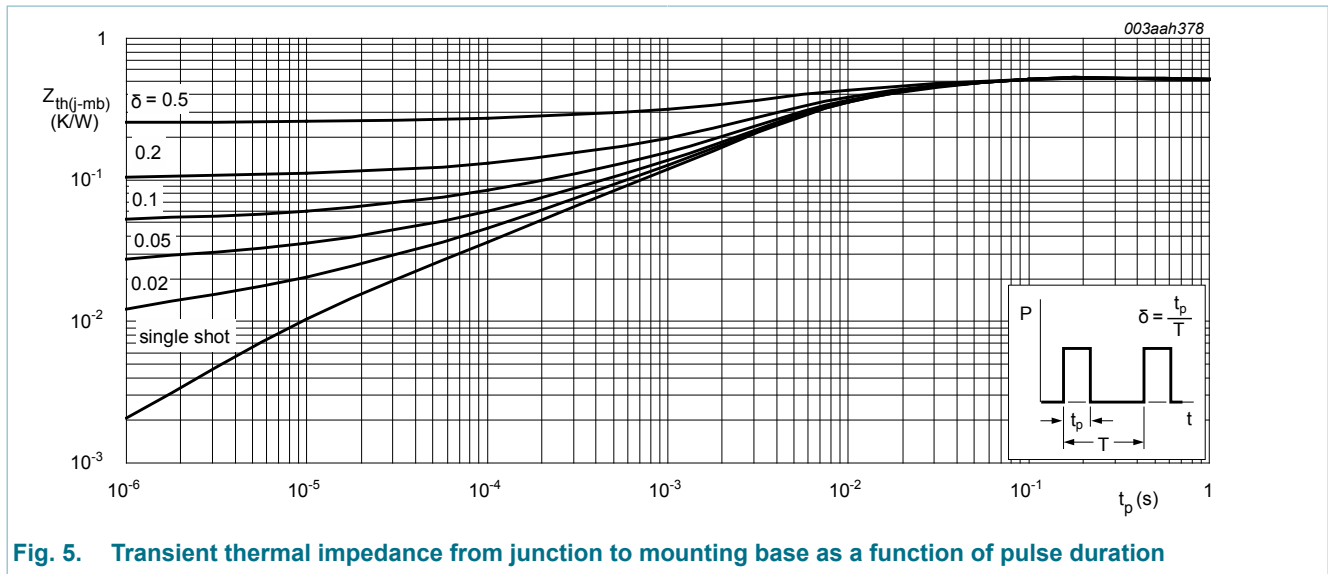


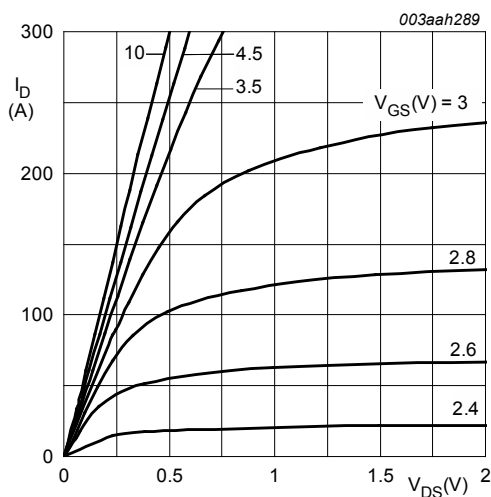
Fig. 5. Transient thermal impedance from junction to mounting base as a function of pulse duration

## 10. Characteristics

Table 7. Characteristics

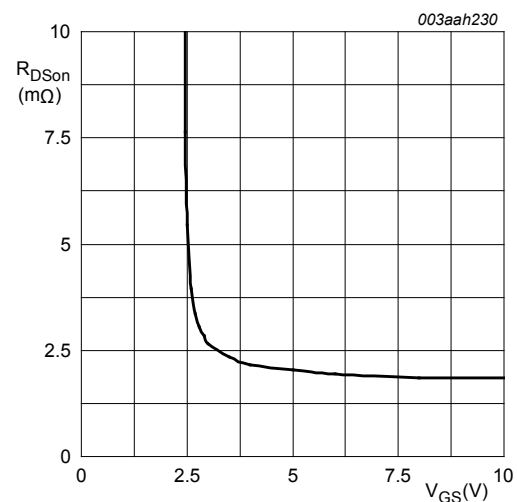
| Symbol                        | Parameter                        | Conditions                                                                           | Min  | Typ  | Max  | Unit    |
|-------------------------------|----------------------------------|--------------------------------------------------------------------------------------|------|------|------|---------|
| <b>Static characteristics</b> |                                  |                                                                                      |      |      |      |         |
| $V_{(BR)DSS}$                 | drain-source breakdown voltage   | $I_D = 250 \mu A; V_{GS} = 0 V; T_J = 25 ^\circ C$                                   | 40   | -    | -    | V       |
|                               |                                  | $I_D = 250 \mu A; V_{GS} = 0 V; T_J = -55 ^\circ C$                                  | 36   | -    | -    | V       |
| $V_{GS(th)}$                  | gate-source threshold voltage    | $I_D = 1 mA; V_{DS} = V_{GS}; T_J = 25 ^\circ C;$<br><a href="#">Fig. 9; Fig. 10</a> | 1.4  | 1.7  | 2.1  | V       |
|                               |                                  | $I_D = 1 mA; V_{DS} = V_{GS}; T_J = -55 ^\circ C;$<br><a href="#">Fig. 9</a>         | -    | -    | 2.45 | V       |
|                               |                                  | $I_D = 1 mA; V_{DS} = V_{GS}; T_J = 175 ^\circ C;$<br><a href="#">Fig. 9</a>         | 0.5  | -    | -    | V       |
| $I_{DSS}$                     | drain leakage current            | $V_{DS} = 40 V; V_{GS} = 0 V; T_J = 25 ^\circ C$                                     | -    | 0.15 | 1    | $\mu A$ |
|                               |                                  | $V_{DS} = 40 V; V_{GS} = 0 V; T_J = 175 ^\circ C$                                    | -    | -    | 500  | $\mu A$ |
| $I_{GSS}$                     | gate leakage current             | $V_{GS} = 10 V; V_{DS} = 0 V; T_J = 25 ^\circ C$                                     | -    | 2    | 100  | nA      |
|                               |                                  | $V_{GS} = -10 V; V_{DS} = 0 V; T_J = 25 ^\circ C$                                    | -    | 2    | 100  | nA      |
| $R_{DSon}$                    | drain-source on-state resistance | $V_{GS} = 10 V; I_D = 25 A; T_J = 25 ^\circ C;$<br><a href="#">Fig. 11</a>           | -    | 1.8  | 2.2  | mΩ      |
|                               |                                  | $V_{GS} = 4.5 V; I_D = 25 A; T_J = 25 ^\circ C;$<br><a href="#">Fig. 11</a>          | -    | 2.2  | 2.6  | mΩ      |
|                               |                                  | $V_{GS} = 10 V; I_D = 25 A; T_J = 175 ^\circ C;$<br><a href="#">Fig. 12; Fig. 11</a> | -    | -    | 4.1  | mΩ      |
| $R_G$                         | gate resistance                  | $f = 1 MHz$                                                                          | 0.41 | 0.82 | 1.64 | Ω       |

| Symbol                  | Parameter                    | Conditions                                                                                                                  |  | Min | Typ   | Max | Unit |
|-------------------------|------------------------------|-----------------------------------------------------------------------------------------------------------------------------|--|-----|-------|-----|------|
| Dynamic characteristics |                              |                                                                                                                             |  |     |       |     |      |
| Q <sub>G(tot)</sub>     | total gate charge            | I <sub>D</sub> = 25 A; V <sub>DS</sub> = 32 V; V <sub>GS</sub> = 5 V;<br><a href="#">Fig. 13</a> ; <a href="#">Fig. 14</a>  |  | -   | 87.8  | -   | nC   |
|                         |                              | I <sub>D</sub> = 25 A; V <sub>DS</sub> = 32 V; V <sub>GS</sub> = 10 V;<br><a href="#">Fig. 13</a> ; <a href="#">Fig. 14</a> |  | -   | 168.9 | -   | nC   |
| Q <sub>GS</sub>         | gate-source charge           | I <sub>D</sub> = 25 A; V <sub>DS</sub> = 32 V; V <sub>GS</sub> = 10 V;<br><a href="#">Fig. 14</a> ; <a href="#">Fig. 13</a> |  | -   | 20.8  | -   | nC   |
| Q <sub>GD</sub>         | gate-drain charge            | I <sub>D</sub> = 25 A; V <sub>DS</sub> = 32 V; V <sub>GS</sub> = 10 V;<br><a href="#">Fig. 13</a> ; <a href="#">Fig. 14</a> |  | -   | 29.6  | -   | nC   |
| C <sub>iss</sub>        | input capacitance            | V <sub>GS</sub> = 0 V; V <sub>DS</sub> = 25 V; f = 1 MHz;<br>T <sub>j</sub> = 25 °C; <a href="#">Fig. 15</a>                |  | -   | 9584  | -   | pF   |
| C <sub>oss</sub>        | output capacitance           |                                                                                                                             |  | -   | 1190  | -   | pF   |
| C <sub>rss</sub>        | reverse transfer capacitance |                                                                                                                             |  | -   | 585   | -   | pF   |
| t <sub>d(on)</sub>      | turn-on delay time           | V <sub>DS</sub> = 30 V; R <sub>L</sub> = 1.2 Ω; V <sub>GS</sub> = 5 V;<br>R <sub>G(ext)</sub> = 5 Ω                         |  | -   | 56    | -   | ns   |
| t <sub>r</sub>          | rise time                    |                                                                                                                             |  | -   | 96    | -   | ns   |
| t <sub>d(off)</sub>     | turn-off delay time          |                                                                                                                             |  | -   | 151   | -   | ns   |
| t <sub>f</sub>          | fall time                    |                                                                                                                             |  | -   | 93    | -   | ns   |
| Source-drain diode      |                              |                                                                                                                             |  |     |       |     |      |
| V <sub>SD</sub>         | source-drain voltage         | I <sub>S</sub> = 25 A; V <sub>GS</sub> = 0 V; T <sub>j</sub> = 25 °C; <a href="#">Fig. 16</a>                               |  | -   | 0.8   | 1.2 | V    |
| t <sub>rr</sub>         | reverse recovery time        | I <sub>S</sub> = 20 A; dI <sub>S</sub> /dt = -100 A/μs; V <sub>GS</sub> = 0 V;<br>V <sub>DS</sub> = 25 V                    |  | -   | 45    | -   | ns   |
| Q <sub>r</sub>          | recovered charge             |                                                                                                                             |  | -   | 62    | -   | nC   |



$T_j = 25\text{ }^\circ\text{C}$ ;  $t_p = 300\text{ }\mu\text{s}$

**Fig. 6.** Output characteristics; drain current as a function of drain-source voltage; typical values



$T_j = 25\text{ }^\circ\text{C}$ ;  $I_D = 25\text{ A}$

**Fig. 7.** Drain-source on-state resistance as a function of gate-source voltage; typical values

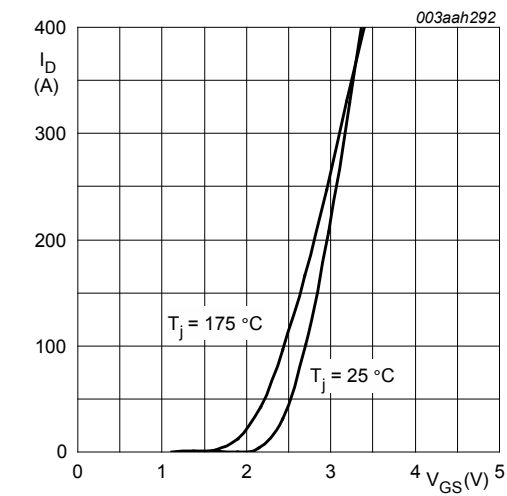


Fig. 8. Transfer characteristics; drain current as a function of gate-source voltage; typical values

$V_{DS} = 10V$

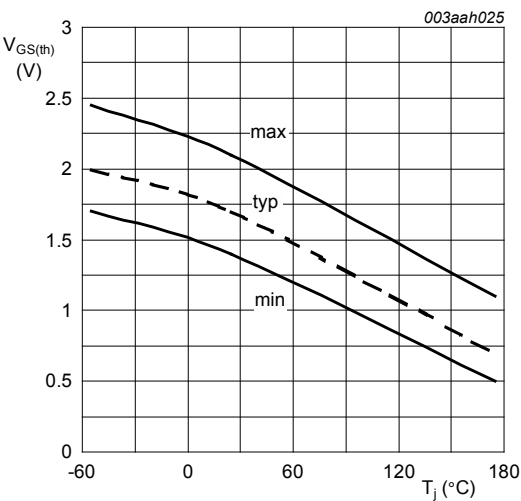


Fig. 9. Gate-source threshold voltage as a function of junction temperature

$I_D = 1\text{ mA}; V_{DS} = V_{GS}$

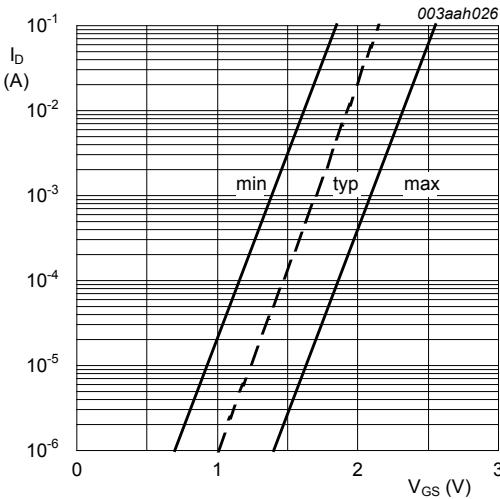
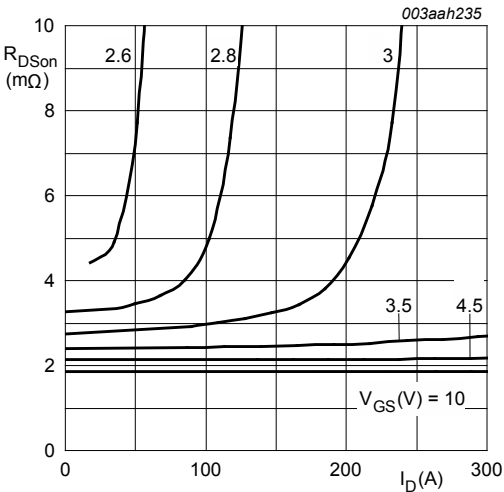


Fig. 10. Sub-threshold drain current as a function of gate-source voltage

$T_j = 25\text{ °C}; V_{DS} = 5V$



$T_j = 25\text{ °C}; t_p = 300\text{ }\mu\text{s}$

Fig. 11. Drain-source on-state resistance as a function of drain current; typical values

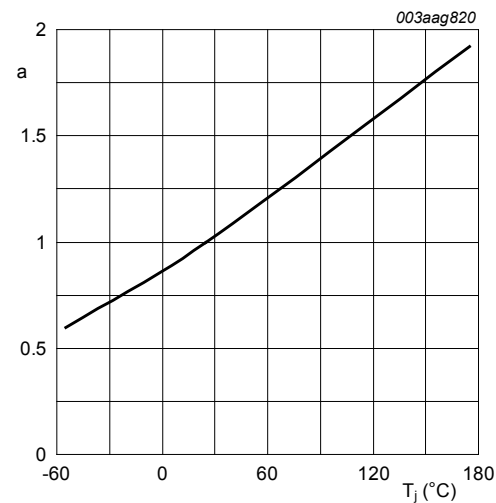


Fig. 12. Normalized drain-source on-state resistance factor as a function of junction temperature

$$a = \frac{R_{DSon}}{R_{DSon(25\text{ }^{\circ}\text{C})}}$$

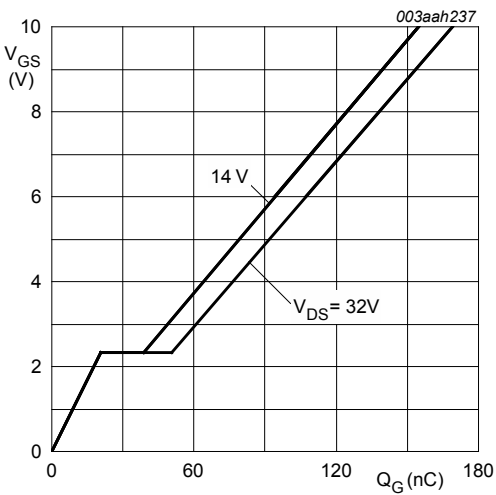


Fig. 14. Gate-source voltage as a function of gate charge; typical values

$$T_j = 25^{\circ}\text{C}; I_D = 25\text{ A}$$

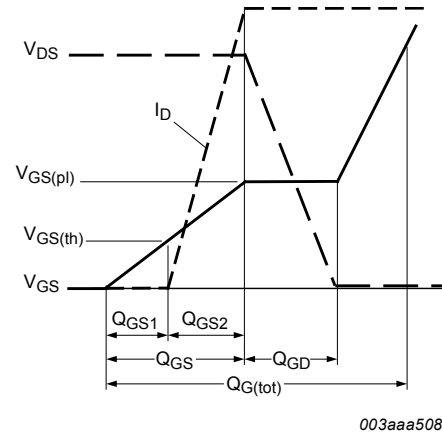


Fig. 13. Gate charge waveform definitions

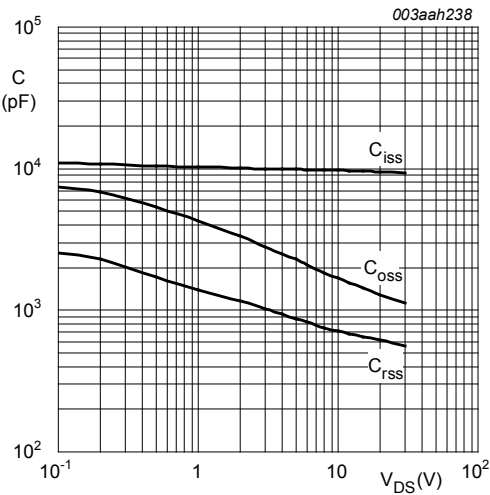


Fig. 15. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values

$$V_{GS} = 0\text{ V}; f = 1\text{ MHz}$$



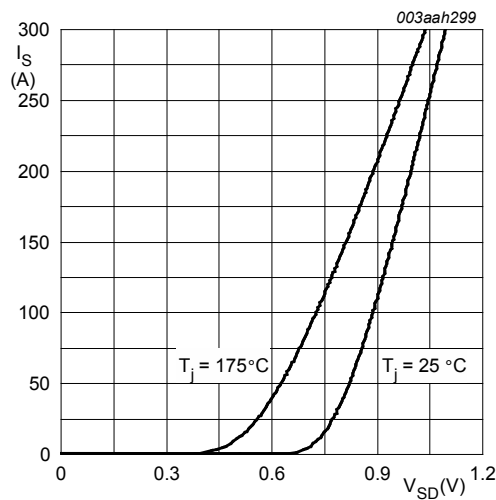


Fig. 16. Source (diode forward) current as a function of source-drain (diode forward) voltage; typical values

$V_{GS} = 0V$

11. Package outline

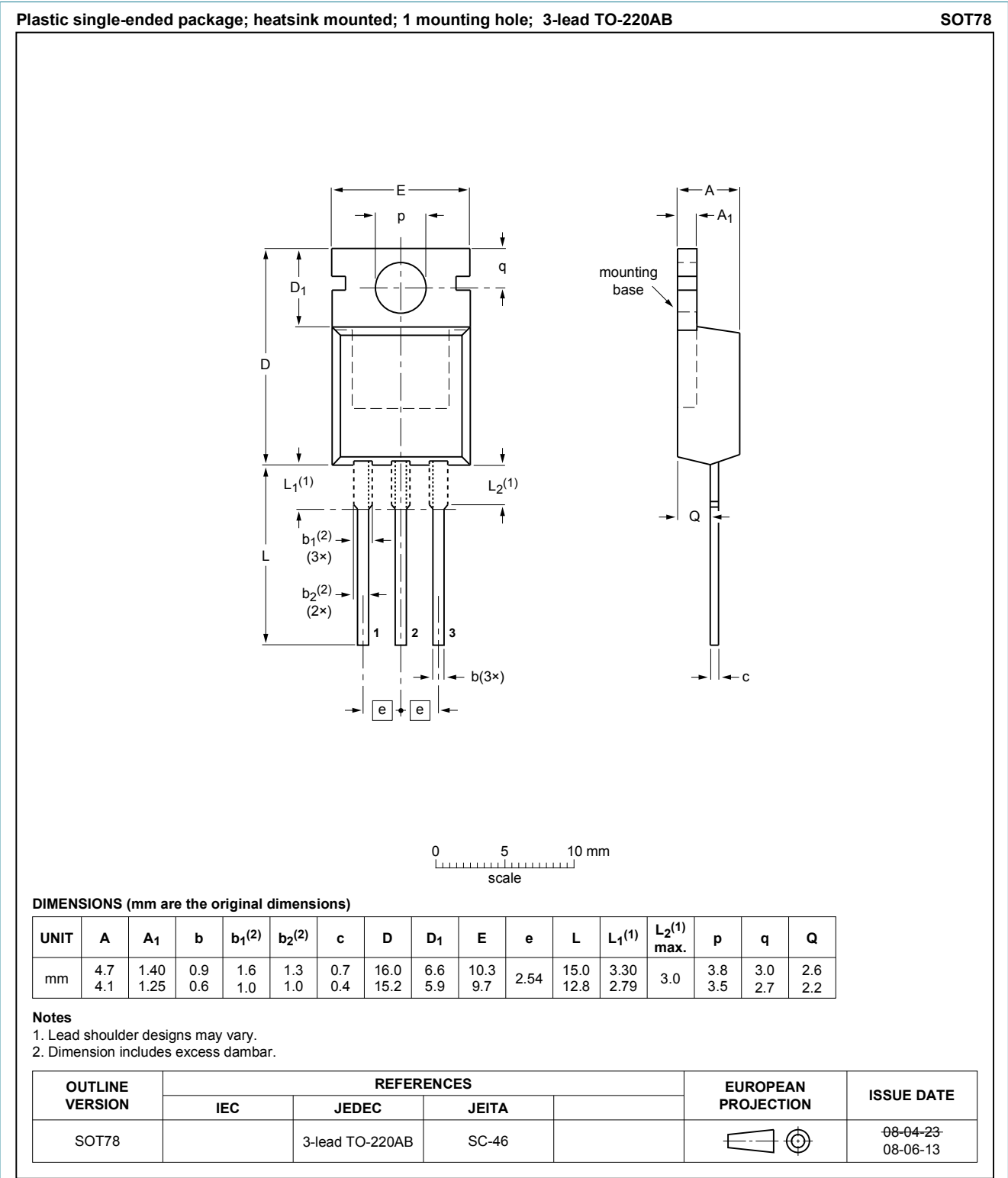


Fig. 17. Package outline TO-220AB (SOT78)

## 12. Legal information

### 12.1 Data sheet status

| Document status [1][2]         | Product status [3] | Definition                                                                            |
|--------------------------------|--------------------|---------------------------------------------------------------------------------------|
| Objective [short] data sheet   | Development        | This document contains data from the objective specification for product development. |
| Preliminary [short] data sheet | Qualification      | This document contains data from the preliminary specification.                       |
| Product [short] data sheet     | Production         | This document contains the product specification.                                     |

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions".
- [3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL <http://www.nxp.com>.

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